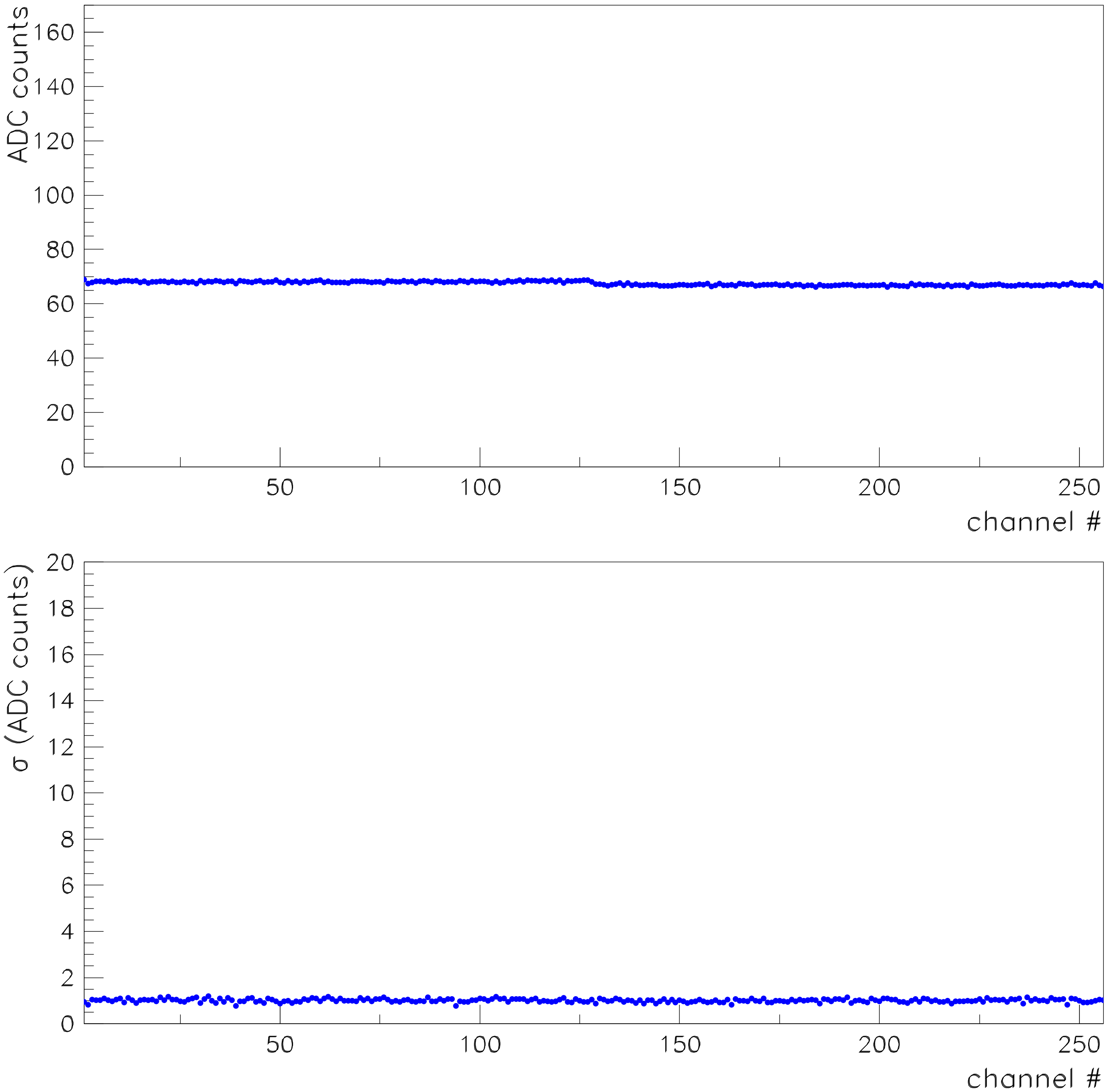
2004/09/28 11.02

Ped and sigma ped: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:43:04 CD



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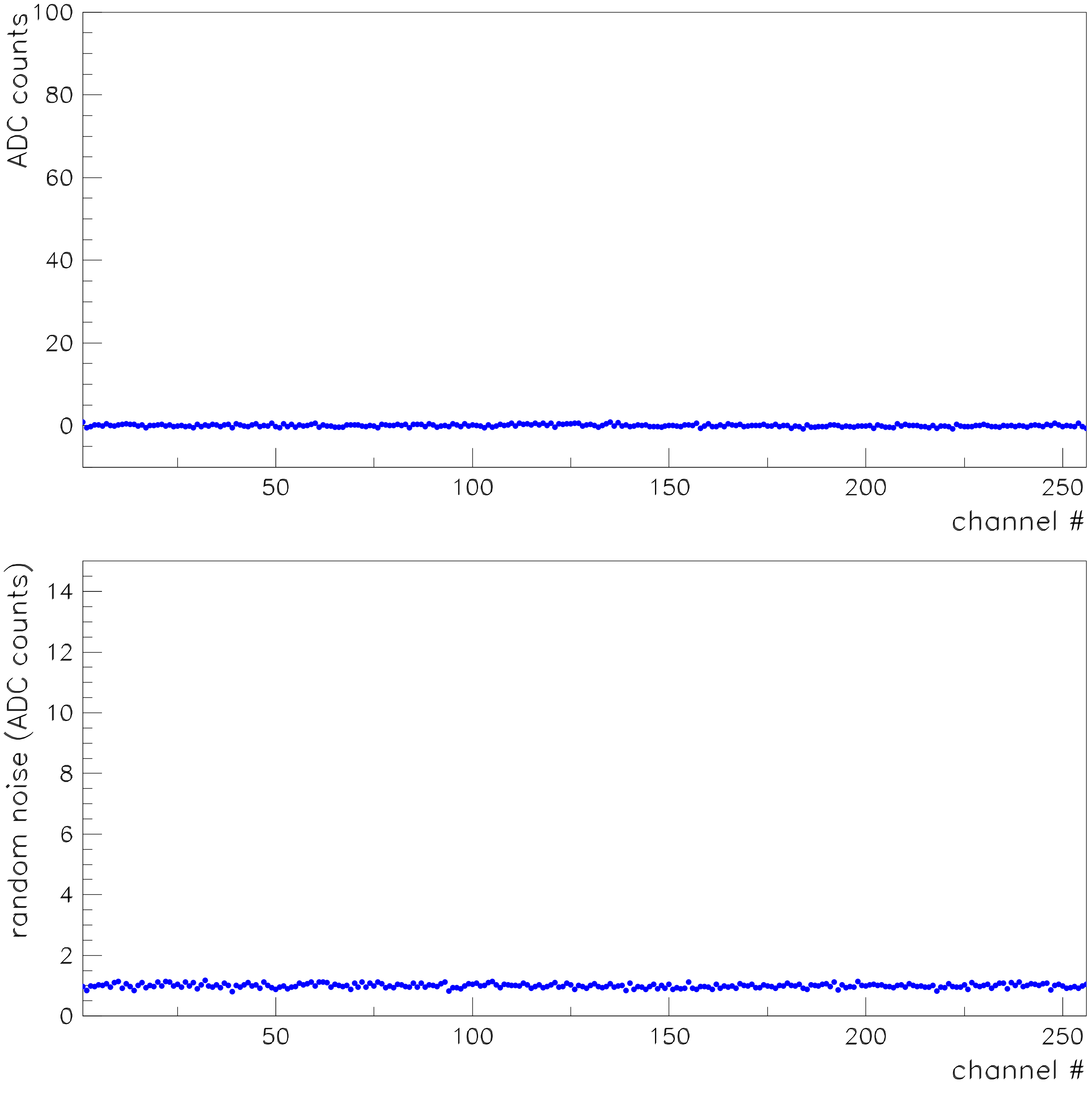
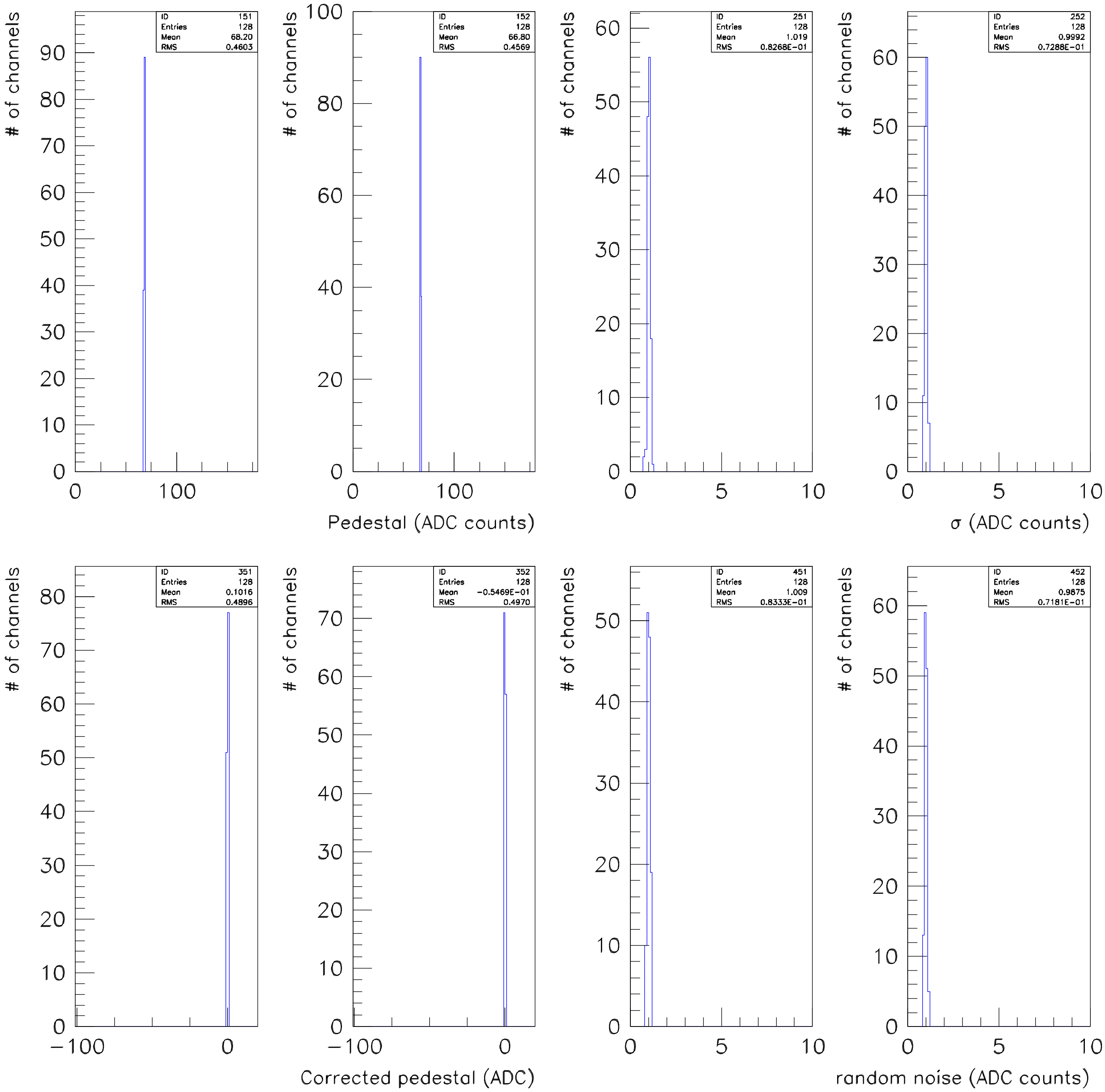
Cor_ped and random noise: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:4



2004/09/28 11.02

Ped and sigma ped distributions: L2 hlo-309-c, side p run 8, test date 'Wed Sep



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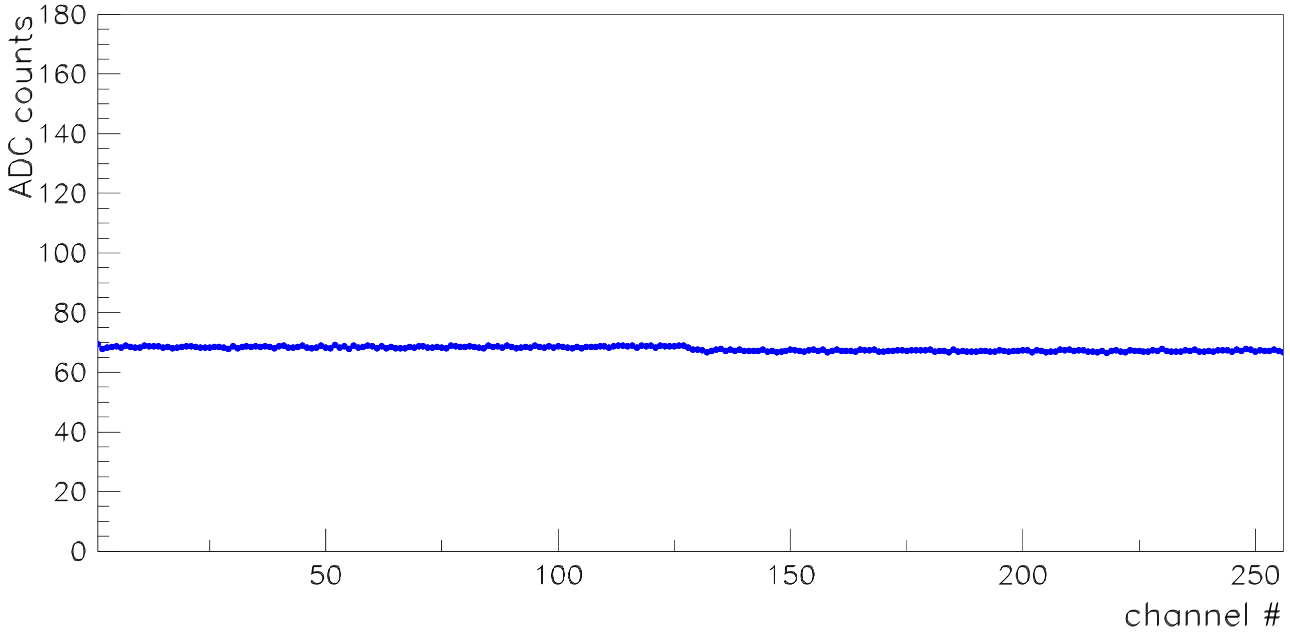
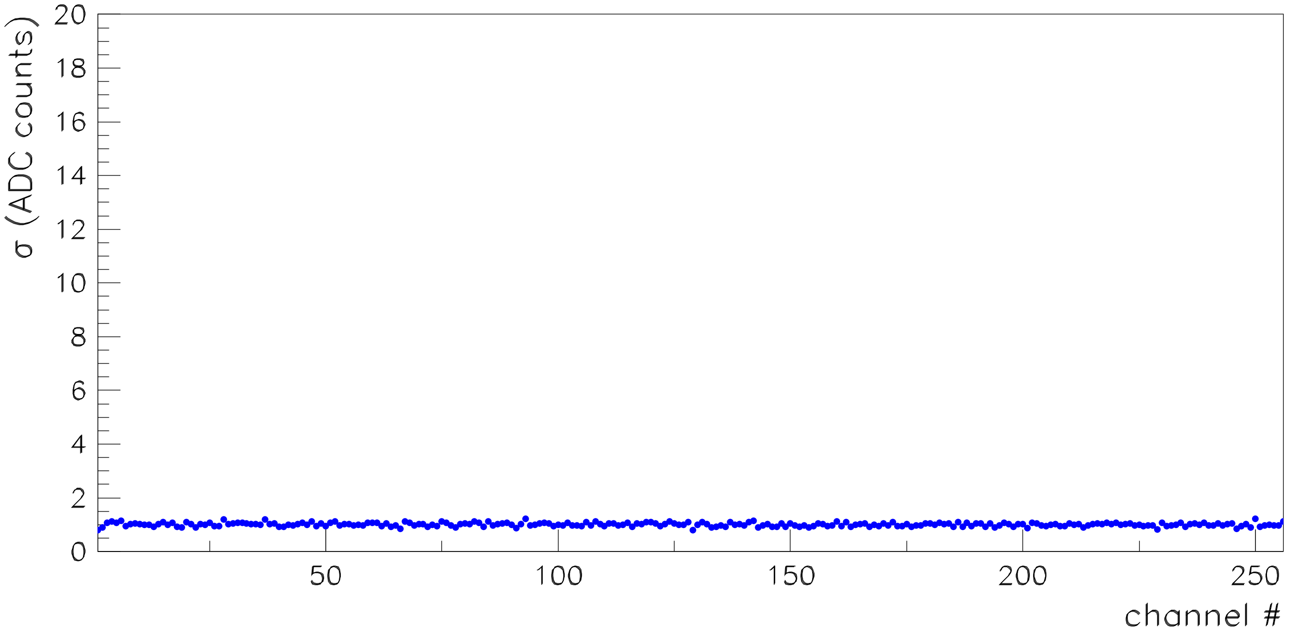
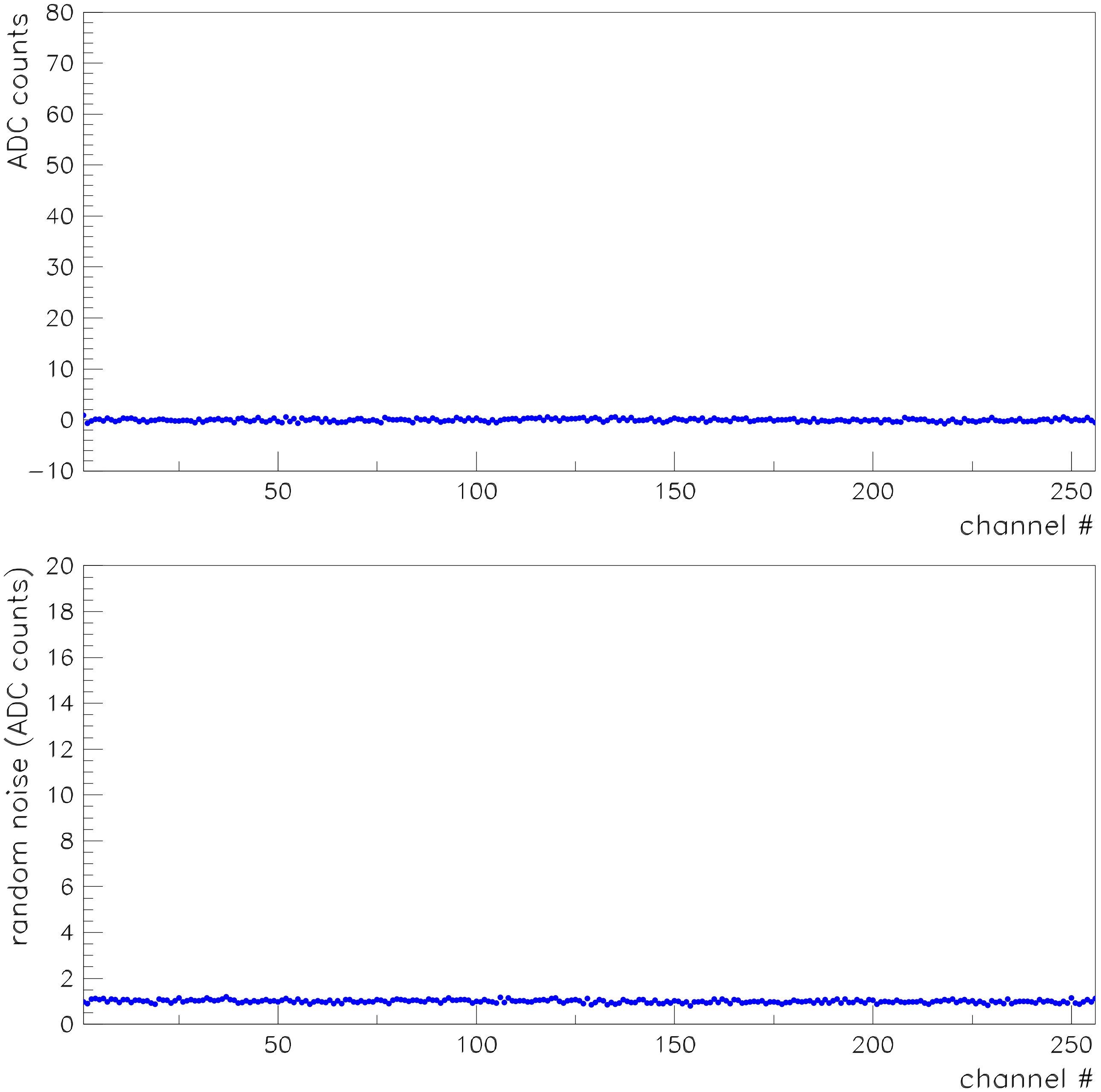
Ped cal and sigma ped: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:43:0





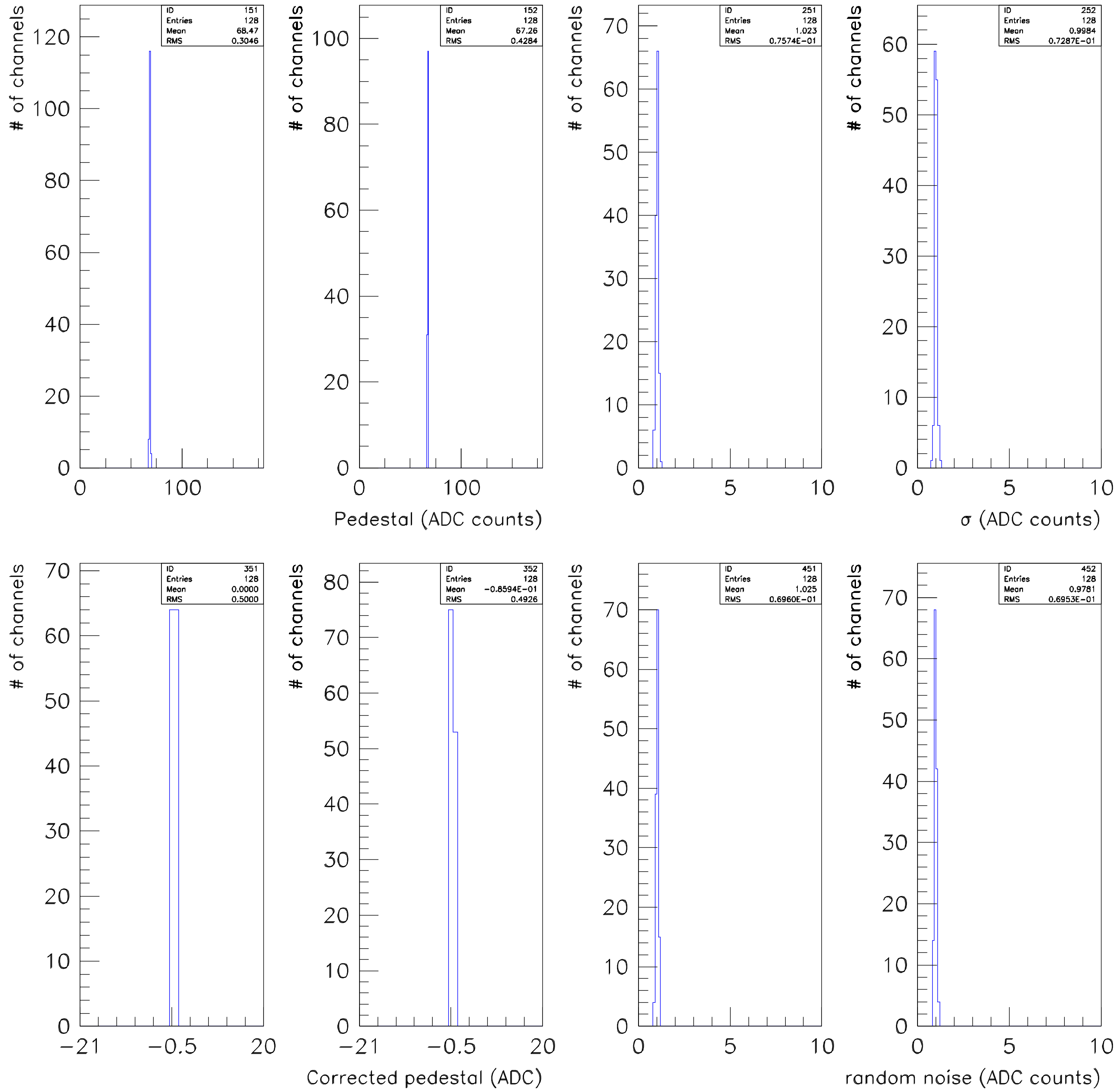
2004/09/28 11.02

Cor_ped and random noise: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:4



2004/09/28 11.02

Ped and sigma ped distributions: L2 hlo-309-c, side p run 8, test date 'Wed Sep



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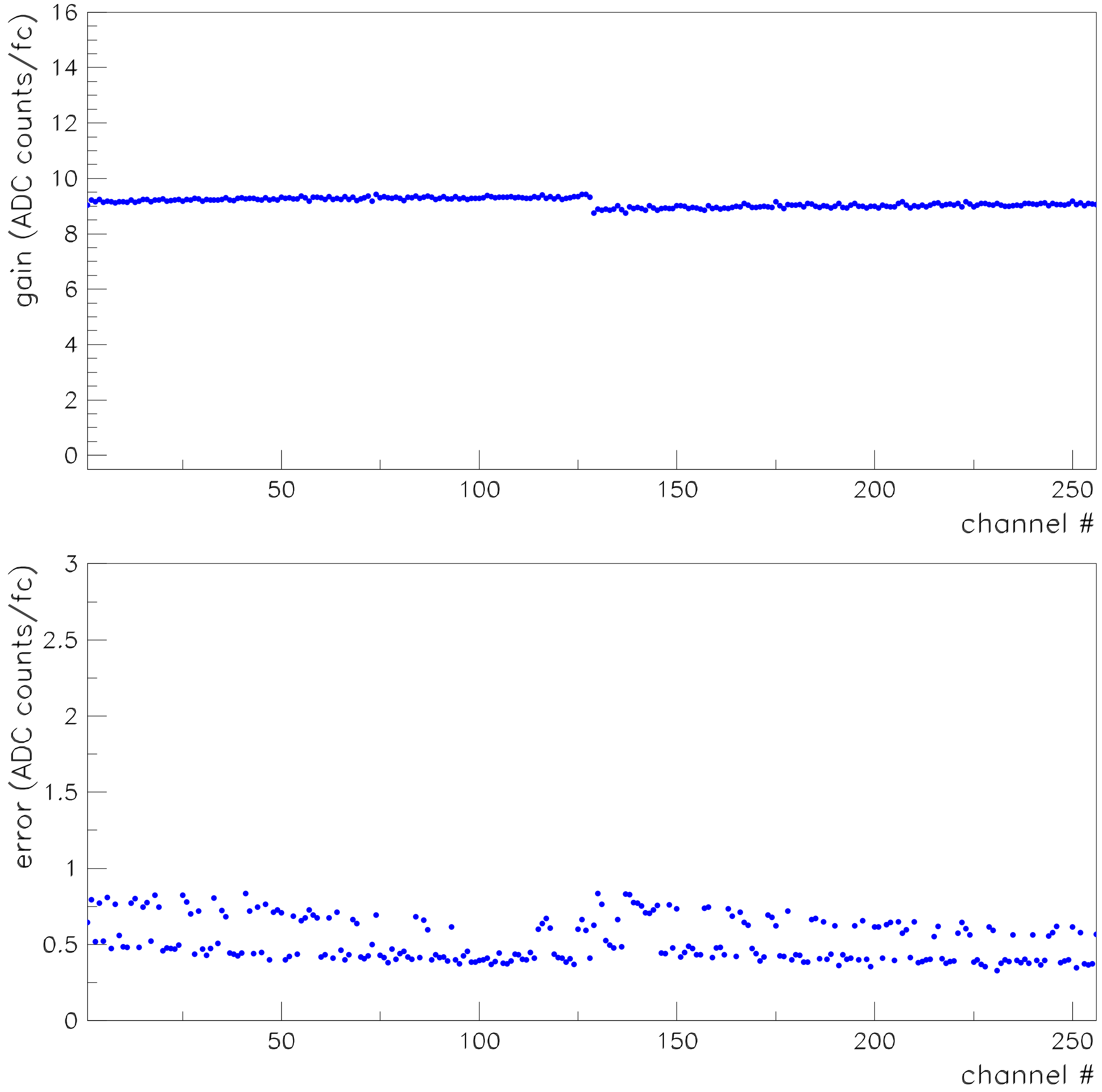
Gain and gain error: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:43:04



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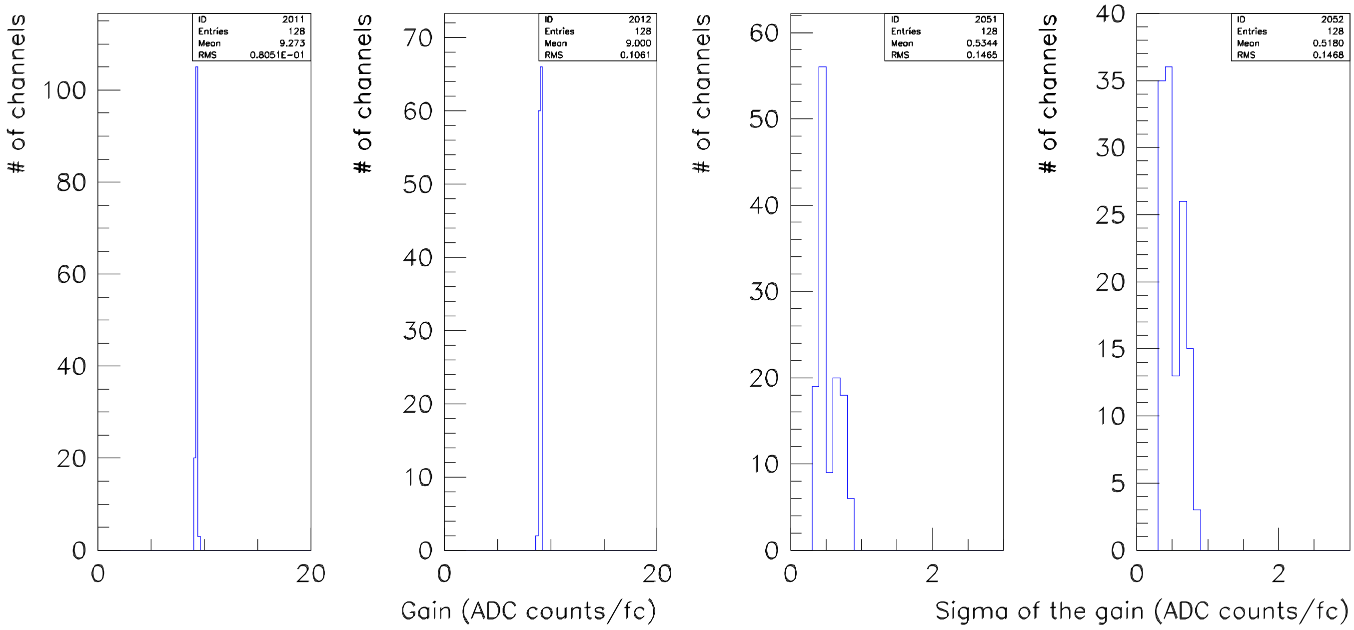
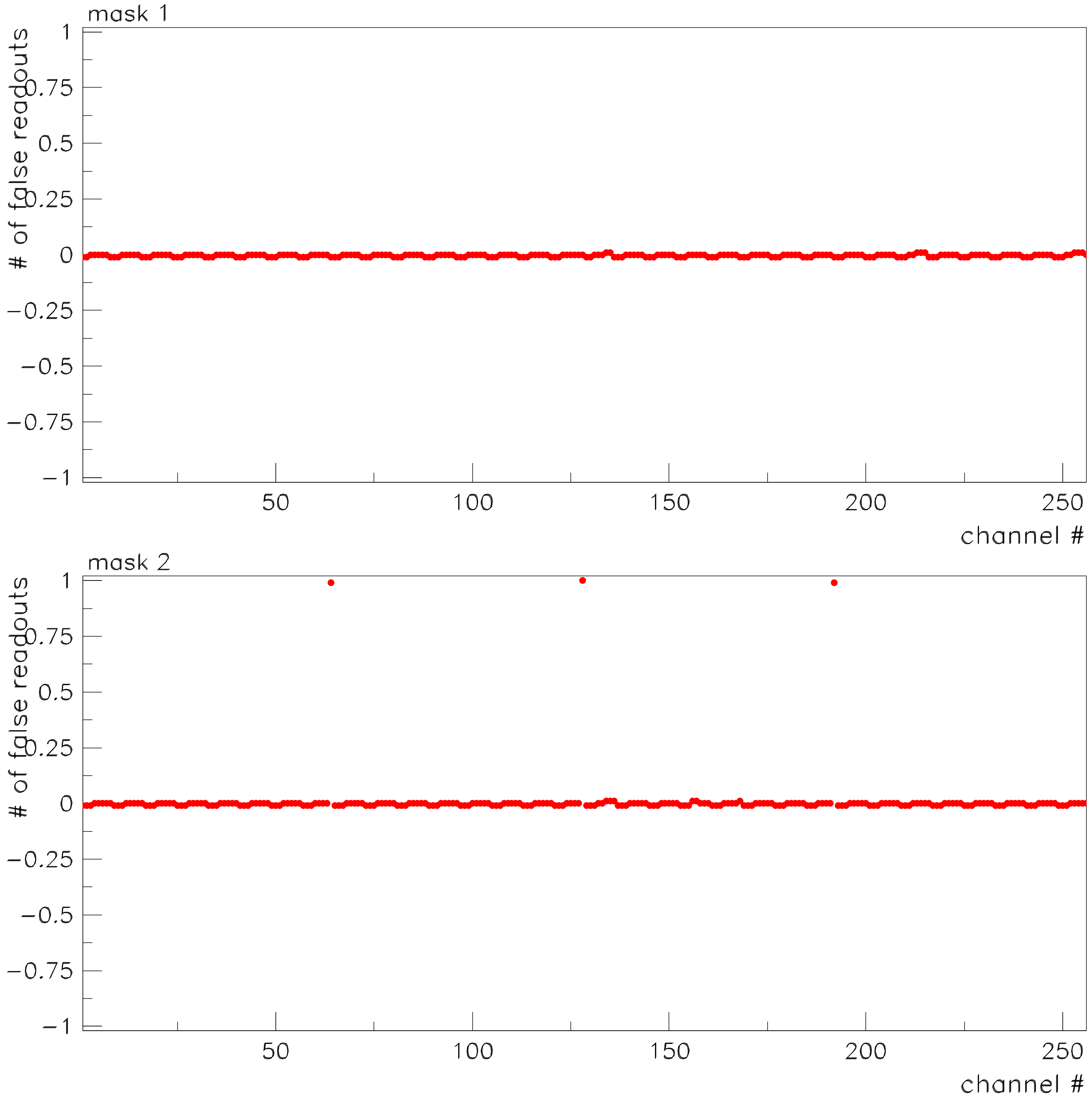
Chip gain distribution: L2 hlo-309-c, side p run 8, test date 'Wed Sep 22 15:43:



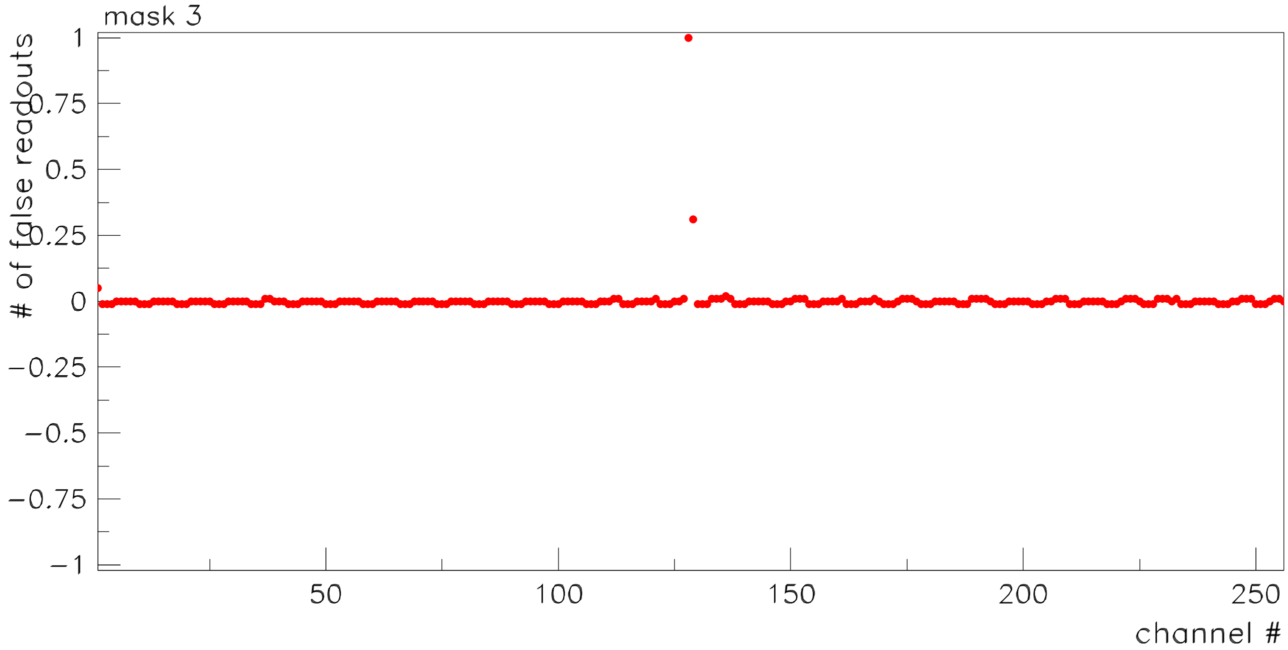
2004/09/28 11.02

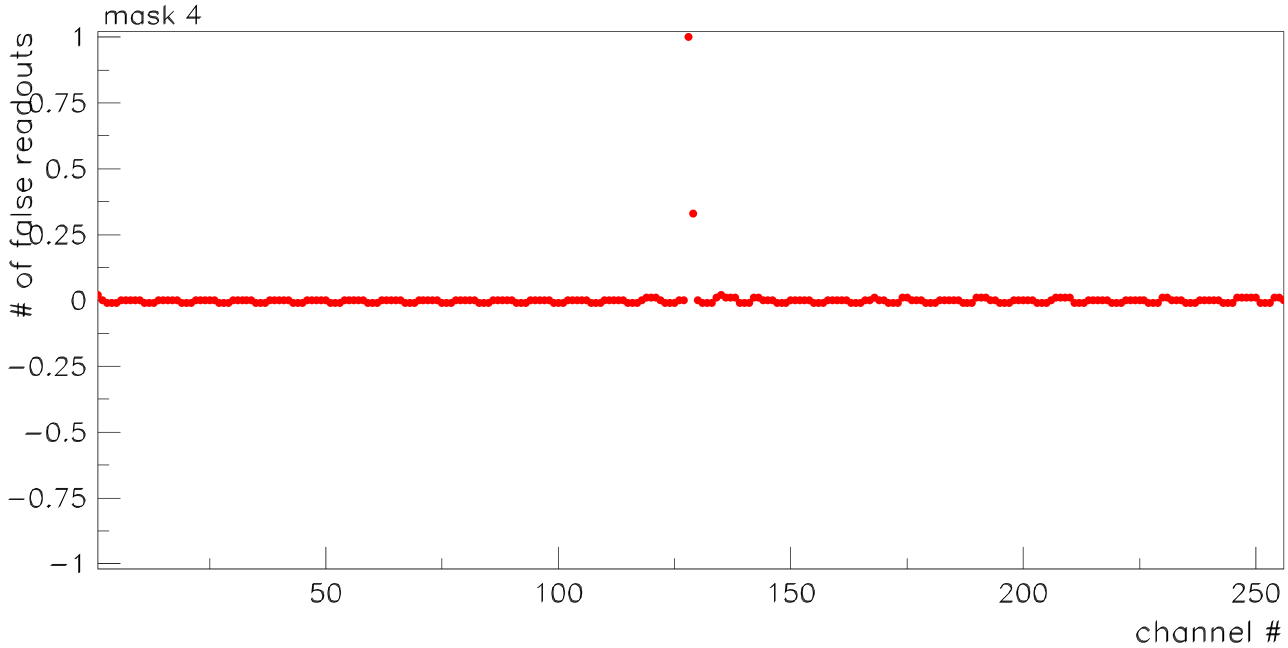
Sparse readout for device L2 hlo-309-c, side p run 8



2004/09/28 11.02

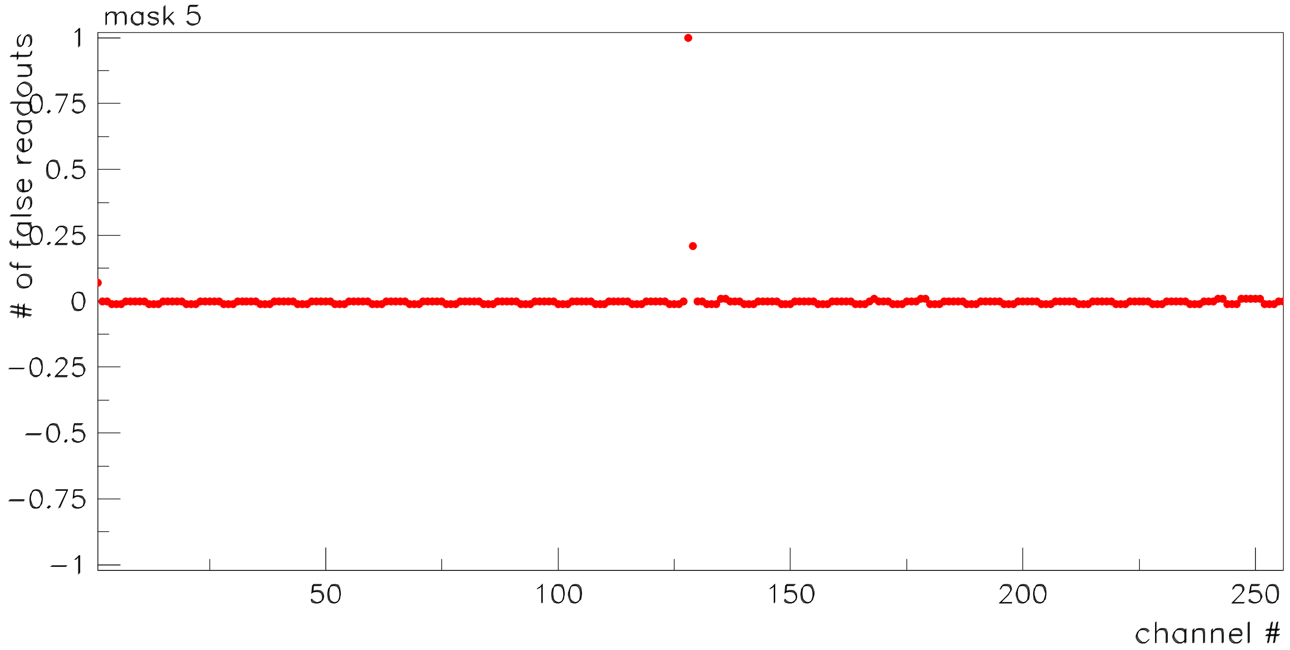
Sparse readout for device L2 hlo-309-c, side p run 8

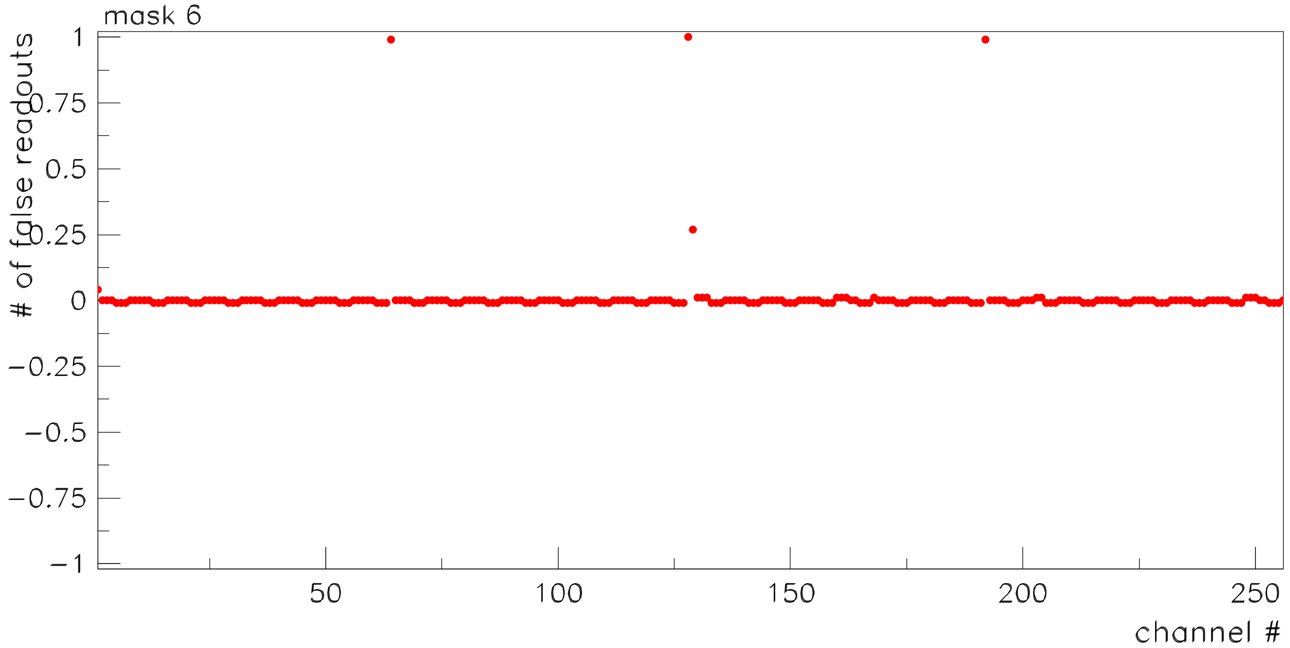




2004/09/28 11.02

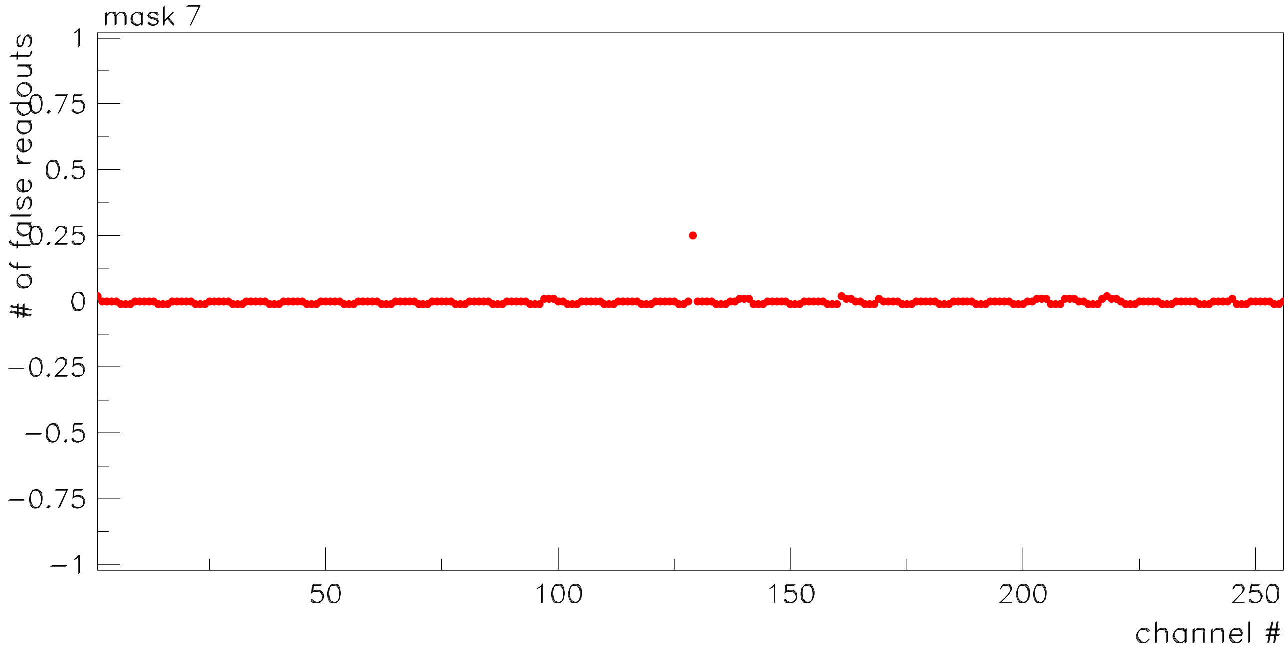
Sparse readout for device L2 hlo-309-c, side p run 8

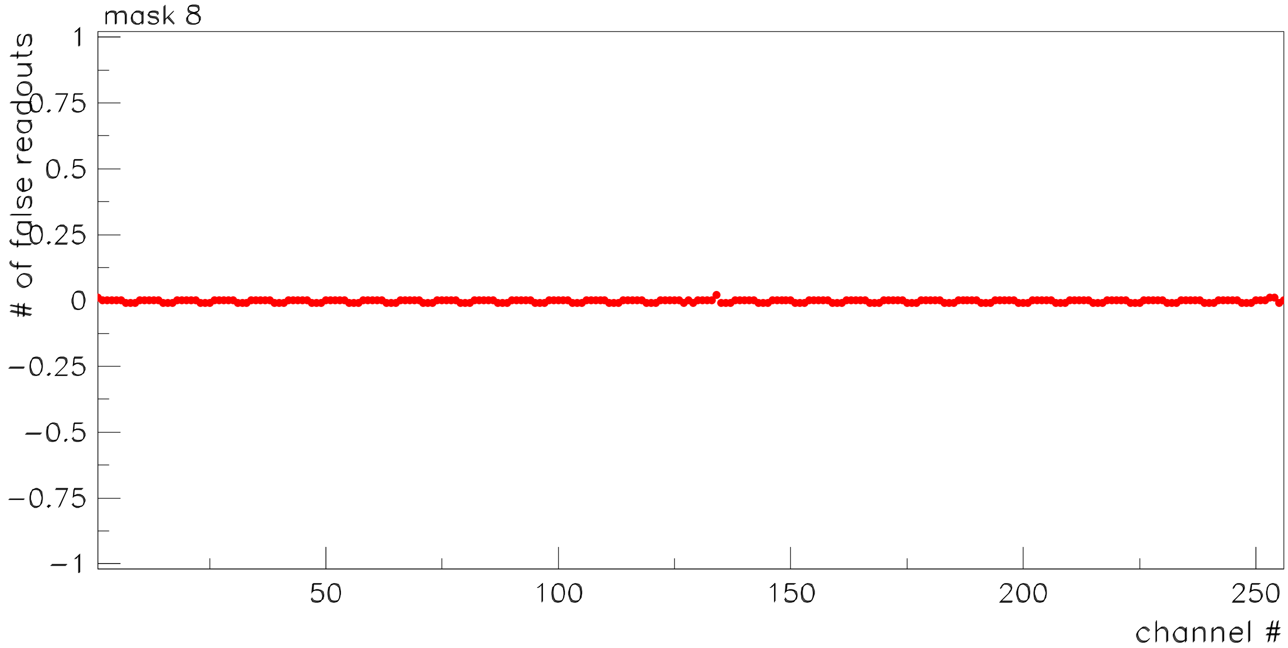


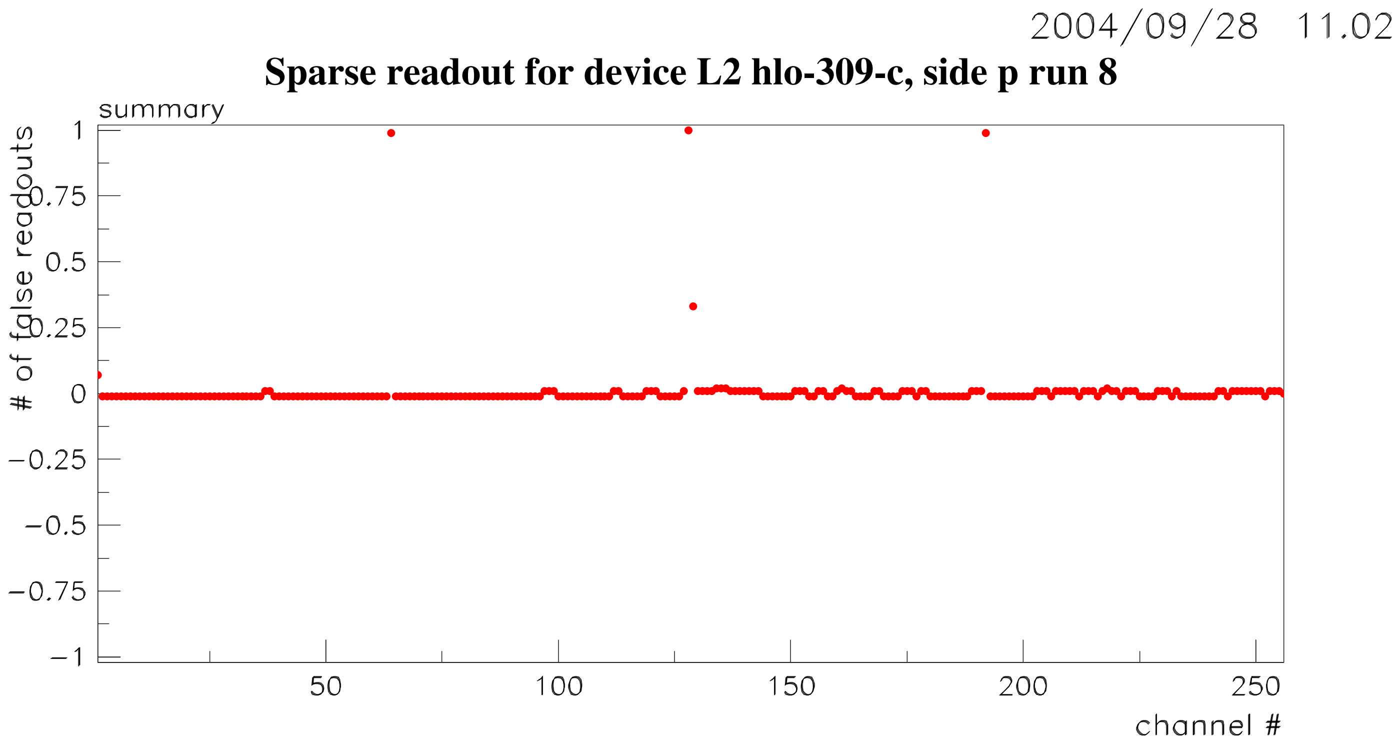


2004/09/28 11.02

Sparse readout for device L2 hlo-309-c, side p run 8







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Sparse readout for device L2 hlo-309-c, side p run 8
summary
# of false readouts
1
0.75
0.5
0.25
0
−0.25
−0.5
−0.75
−1
50
100
150
200
250
channel #

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Monitor: device L2 hlo-309-c, test date 'Wed Sep 22 15:43:04 CDT 2004'